# Notice of References Cited Application/Control No. 10/602,846 Examiner Carolyn F. Fleary Applicant(s)/Patent Under Reexamination BHATTACHARYA ET AL. Page 1 of 2

## U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                    | Classification |
|---|---|--|-----------------|-------------------------|----------------|
|   | Α | US-2004/0193943 A1                               | 09-2004         | Angelino et al.         | 714/004        |
|   | В | US-2004/0153533 A1                               | 08-2004         | Lewis, Lundy M.         | 709/223        |
|   | С | US-2003/0088788 A1                               | 05-2003         | Yang, Xuechen           | 713/201        |
|   | D | US-2004/0098623 A1                               | 05-2004         | Scheidell, Michael      | 713/201        |
|   | E | US-2003/0154399 A1                               | 08-2003         | Zuk et al.              | 713/201        |
|   | F | US-6,496,935 B1                                  | 12-2002         | Fink et al.             | 713/201        |
|   | G | US-2004/0049693 A1                               | 03-2004         | Douglas, Kevin          | 713/200        |
|   | н | US-6,324,647 B1                                  | 11-2001         | Bowman-Amuah, Michel K. | 713/201        |
|   | 1 | US-6,829,239                                     | 12-2004         | Bhatia et al.           | 370/392        |
|   | J | US-2004/0073704                                  | 04-2004         | Paunikar et al.         | 709/245        |
|   | Κ | US-6,336,139                                     | 01-2002         | Feridun et al.          | 709/224        |
|   | ٦ | US-6,493,765                                     | 12-2002         | Cunningham et al.       | 709/245        |
|   | М | US-2003/0149766                                  | 08-2003         | Syvanne et al.          | 709/224        |

### FOREIGN PATENT DOCUMENTS

| * |    | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|----|--|-----------------|---------|------|----------------|
|   | N  |  |                 |         |      | ·              |
|   | O. |  |                 |         |      |                |
|   | Р  |  |                 |         | -    |                |
|   | Q  |  |                 |         |      |                |
|   | R  | ·  |                 |         |      |                |
|   | s  |  |                 |         |      | ,              |
|   | Т  |  | ·               |         |      |                |

## **NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)  |  |  |  |  |  |
|---|---|--|--|--|--|--|--|
|   | U | Vinga, Giovanni; Valeur, Fredrik; Kemmerer, Richard A., Designing and Implementing a Family of Intrusion Detection Systems Septeber 1-5, 2003, ESEC/FSE '03, Helksink, Finland 2003 ACM Inc. |  |  |  |  |  |
|   | ٧ | Julisch, Klaus, Clustering Instrusion Detection Alarms to Support Root Cause Analysis November 2003, ACM Inc., Vol 6, No 4, Pages 443-471  |  |  |  |  |  |
| • | w | Srisuresh, P.; Holdrege M.; Lucent Technolgies, IP Network Address Translator (NAT) Terminiology and Considerations August 1999, The Internet Society.                                       |  |  |  |  |  |
|   | х | International Business Machines Corporation, Methods for Advanced Event Correlation January 2003 ,Kenneth Mason Publicatins Ltd.   |  |  |  |  |  |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | BHATTACHARYA ET AL. | Examiner | Art Unit | Page 2 of 2

## U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                  | Classification |
|---|---|--|-----------------|-----------------------|----------------|
|   | Α | US-2004/0139228                                  | 07-2004         | Takeda, Yutaka et al. | 709/245        |
|   | В | US-  |                 |                       |                |
|   | C | US-  |                 |                       |                |
|   | D | US-  |                 |                       |                |
|   | Е | US-  |                 |                       |                |
|   | F | US-  |                 |                       |                |
|   | G | US-  |                 |                       |                |
|   | Н | US-  |                 |                       |                |
|   | ı | US-  |                 |                       |                |
|   | 7 | US-  |                 |                       |                |
|   | К | US-  |                 |                       | . =            |
|   | L | US-  |                 |                       |                |
|   | М | US-  |                 |                       |                |

## FOREIGN PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | 0 |  |                 |         |      |                |
|   | Р |  |                 |         |      |                |
|   | Ø |  |                 |         | ·    |                |
|   | R | :  |                 |         |      |                |
|   | S | ,  |                 |         |      |                |
|   | Т |  |                 |         |      |                |

## **NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | w |   |
|   | x |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.